

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/654,956	PHILP ET AL.	
Examiner	Art Unit	
Matthew D. Matzek	1771	

	SEARCHED					
Class	Subclass	Date	Examiner			
442	2, 12,14,16	12/30/05	мм			

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
105	12/30/05	мм		
ASSIGNER/INVENTUR	12/30/05	мм		
EAST	12/30/05	יייאי		